Notice of References Cited

Application/Control No.

O9/483,504

Examiner

Sudhaker B. Patel, D.Sc.Tech.

Applicant(s)/Patent Under
Reexamination
TENG ET AL.

Art Unit
Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4022777	05-1977	Sam et al	544/338
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	H	US-			
	_	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	9719934	06-1997	wo	Bata et al	
*	0	55167205	12-1980	JP	Kyowa et al	
	Ρ					
	ø					
	R					
	s					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chemical Abstract DN 122:314514, Wozniak et al, also cited as Indian J. Heterocyclic Chem. 4/2.75-80(1994).
	٧	Chemical Abstract DN 103:37081 for CASRN 97183-62-5.
	w	Chemical Abstract DN 92:76440 for CASRN # 52312-40-0.
	х	Chemical Abstract DN117:192207 for CASRN# 143309087-9P

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.	Applicant(s)/Patent Under Reexamination TENG ET AL.			
09/483,504				
Examiner	Art Unit			
Sudhaker B. Patel, D.Sc.Tech.	1624	Page 2 of 3		

U.S. PATENT DOCUMENTS

	O.S. F. A.E.M. BOSSMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-	۰		
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-		-	
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	σ		·			
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENT BOOMENTO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Chemical Abstract DN 75:129758 for CASRN # 33870-76-7P/7, 33870-77-8.			
	V	Chemical Abstract DN 109:92044 for CASRN # 6640-47-7,90004-55-0P.			
	w	Chemical Abstract DN 115:70795 for CASRN # 34972-22-0.			
	x	Chemical Abstract DN 128:75375 for CASRN#6640-47-7, 200815-10-7P.			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No. 09/483,504	Applicant(s)/Pate Reexamination TENG ET AL.	nt Under .
Examiner	Art Unit	1
Sudhaker B. Patel, D.Sc.Tech.	1624	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			-
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			10 - 10 - 10 - 10 - 10 - 10 - 10 - 10 -
	ı	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					*
	Т			•		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chemical Abstract DN 82:156377, also cited as Englehardt et al, DE 2433397, 2/1975.
	V	Chemical Abstract DN 129:224913, also cited as Page etal, ACS, Inorganic Chem., 37/17/4452-4459(1998).
	w	Chemical Abstract DN 112:179028, also cited as JP 01261389, dated 10/1989.
	х	·

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.